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YOR9200305at151 (RMT) (8728-665)

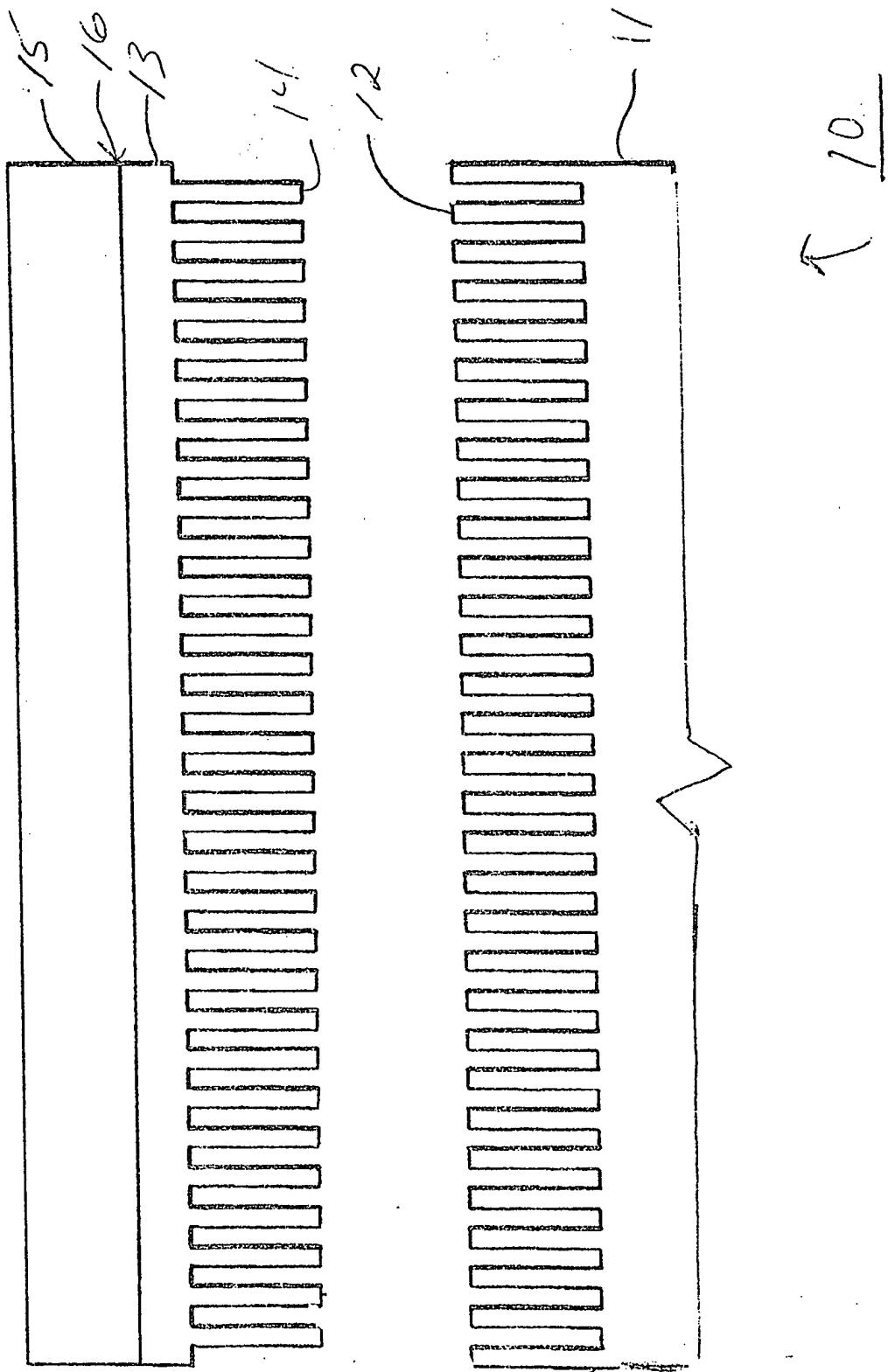


Fig. 1
(Prior Art)

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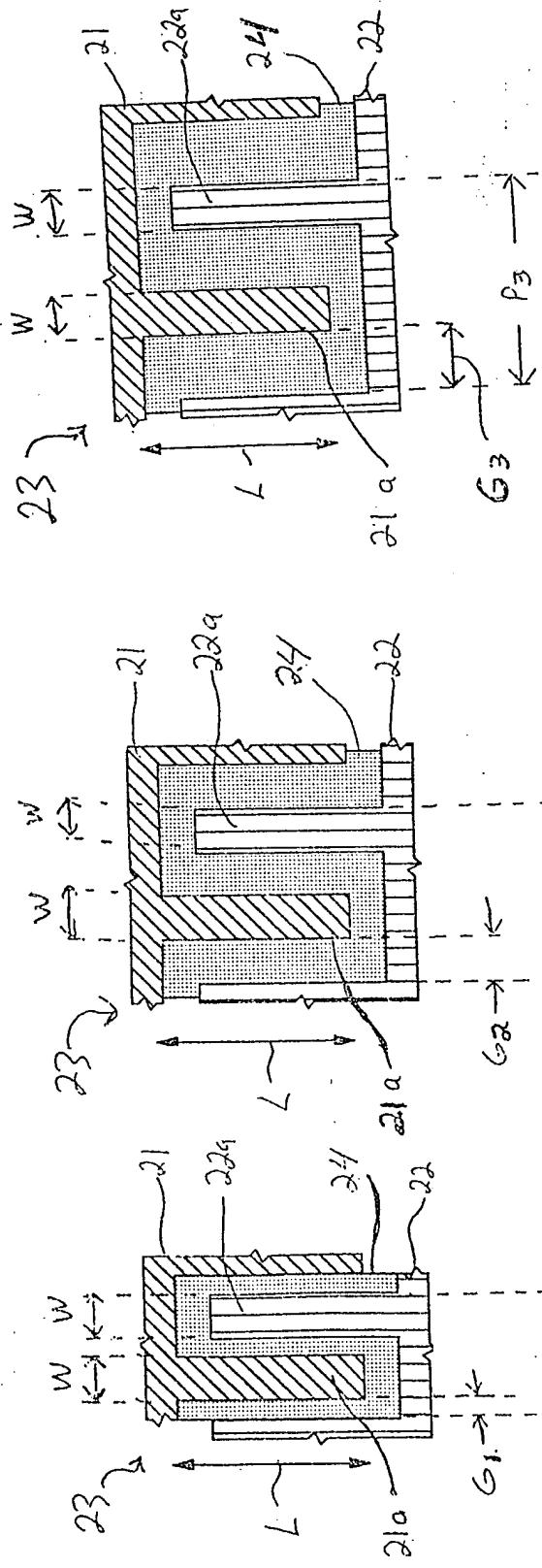
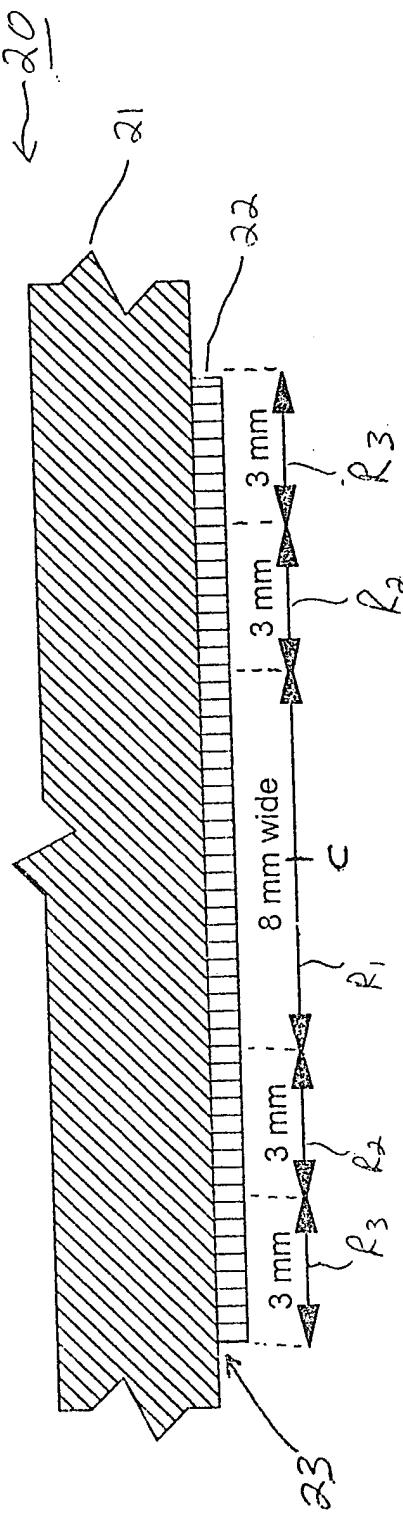


Fig. 2D

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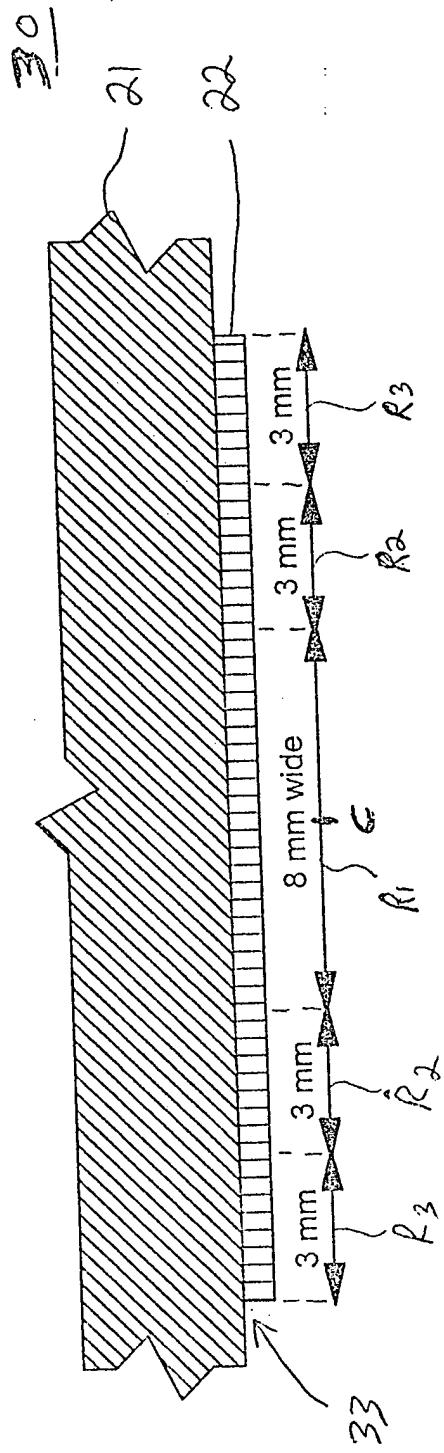


Fig. 3A

Fig. 3A

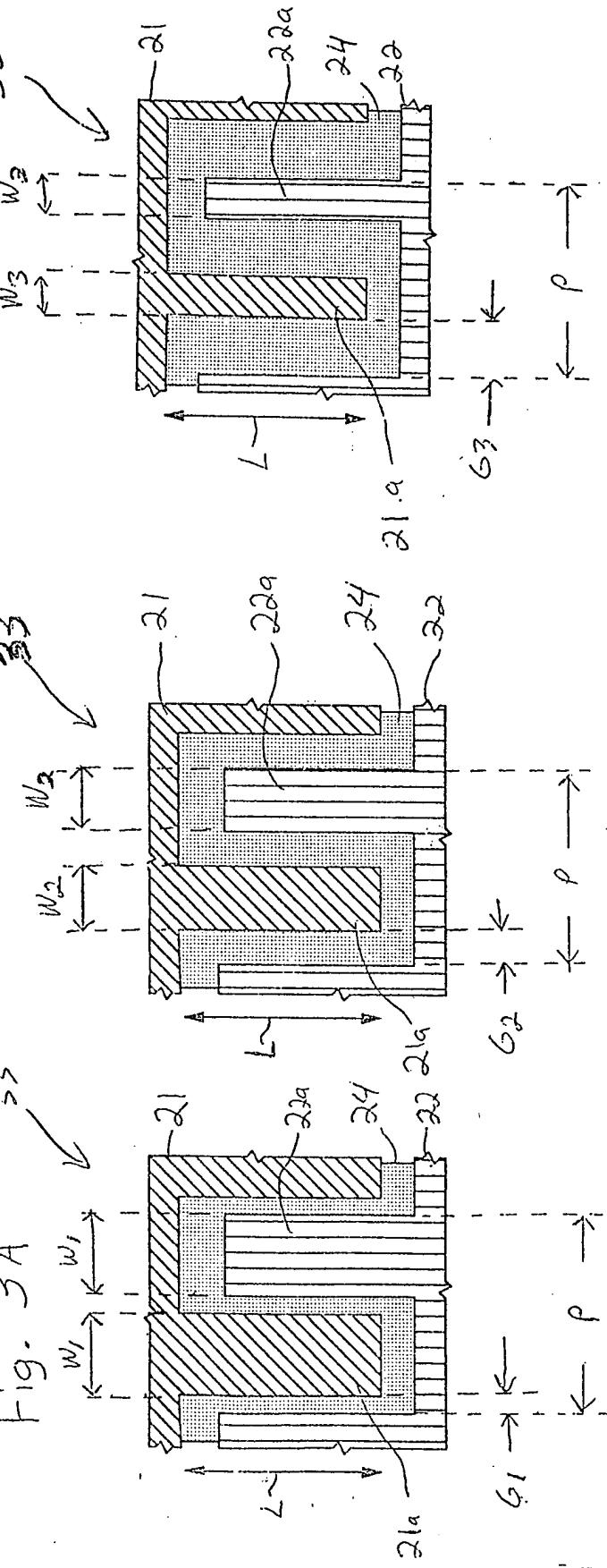
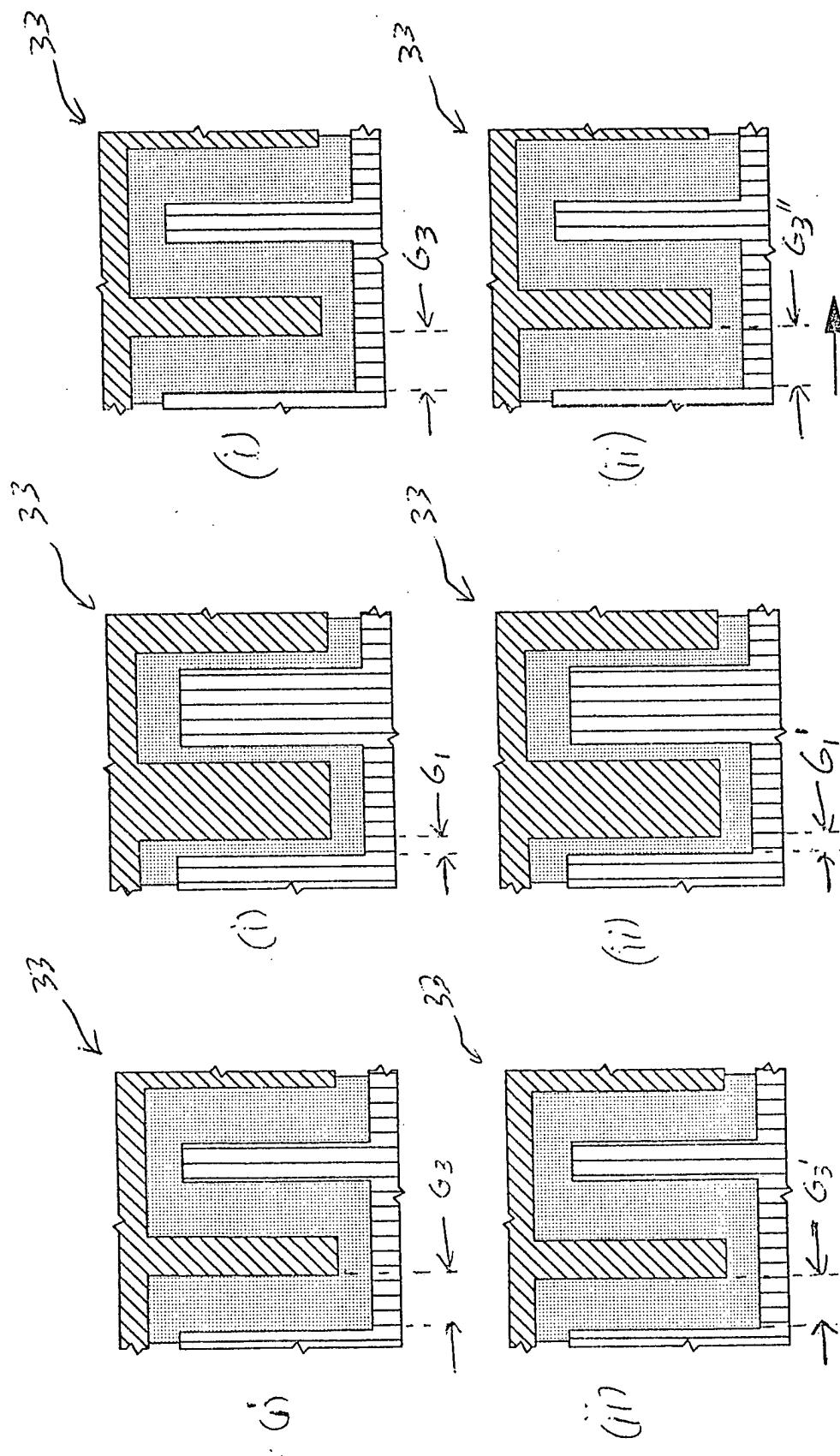


Fig. 3B

Fig. 3C

Fig. 3D

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11 μm shift of Cu vs. Si

Fig. 4/A

Fig. 4/B

Fig. 4/C

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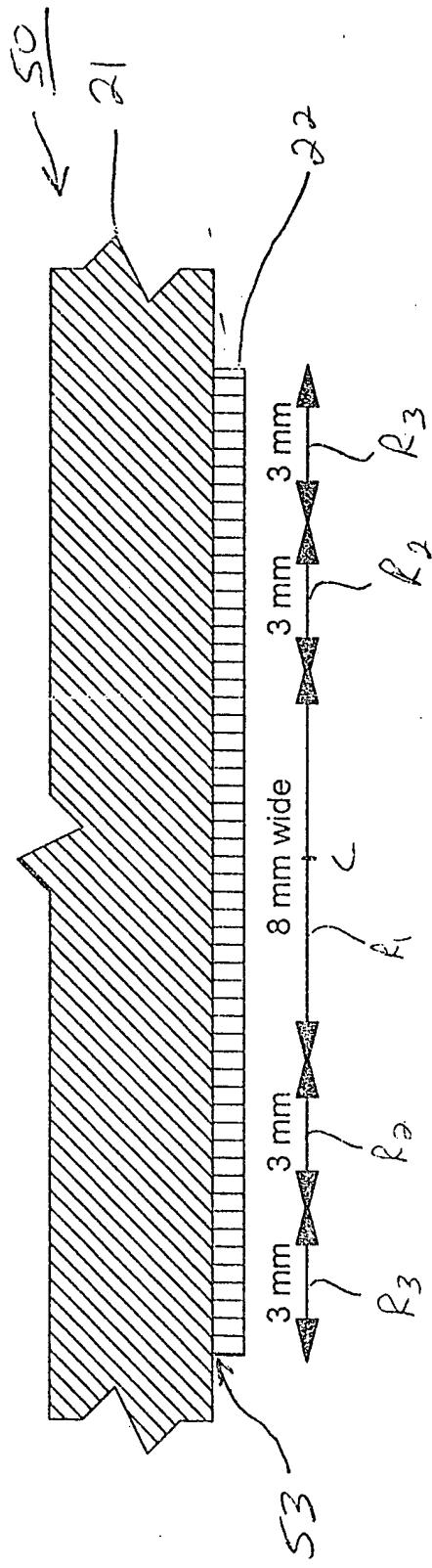


Fig. 5D

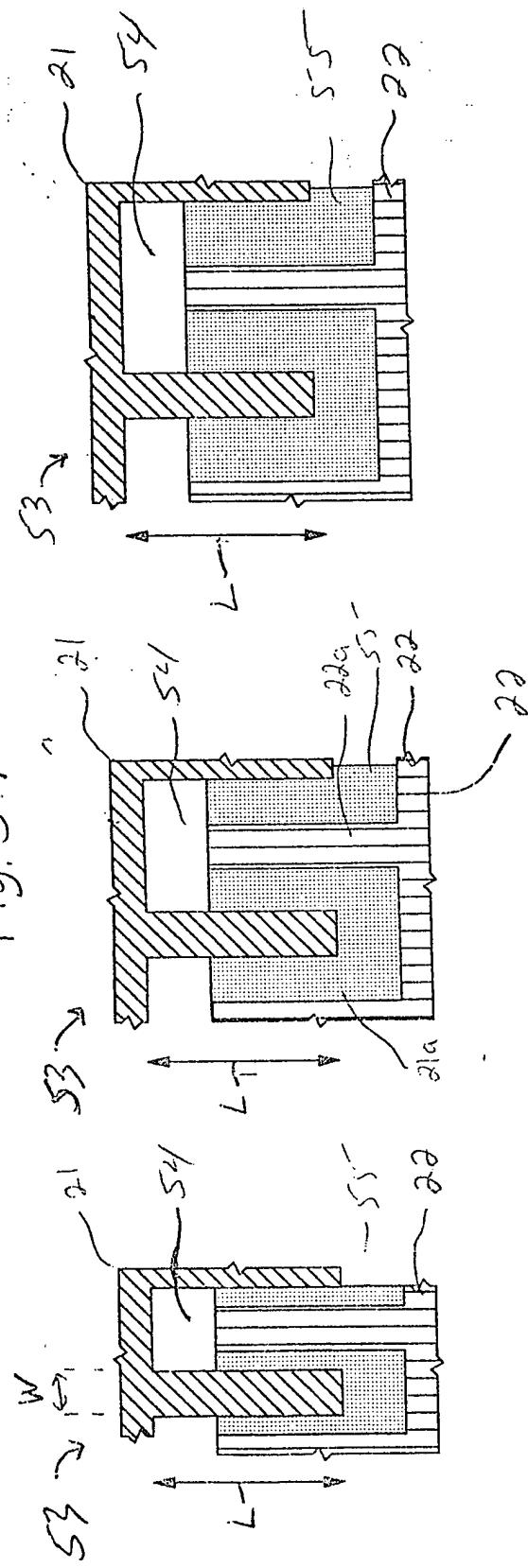


Fig. 5B
Fig. 5C

Fig. 5D

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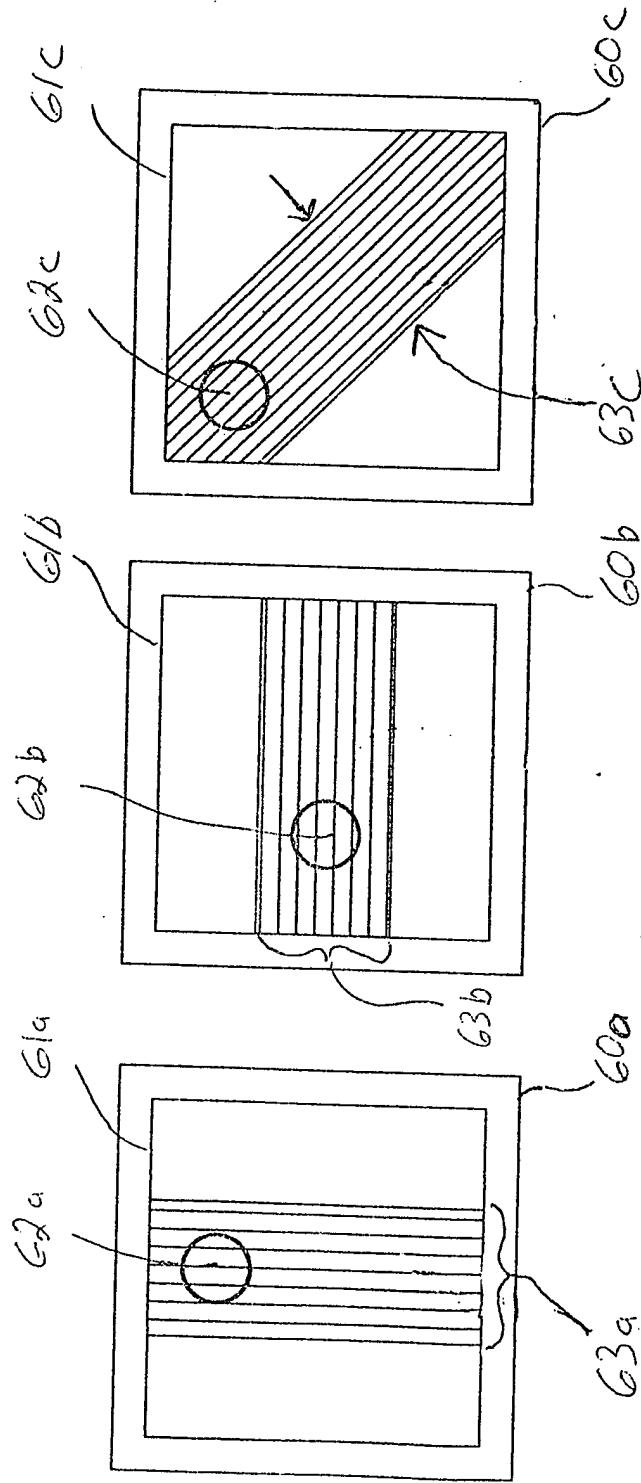


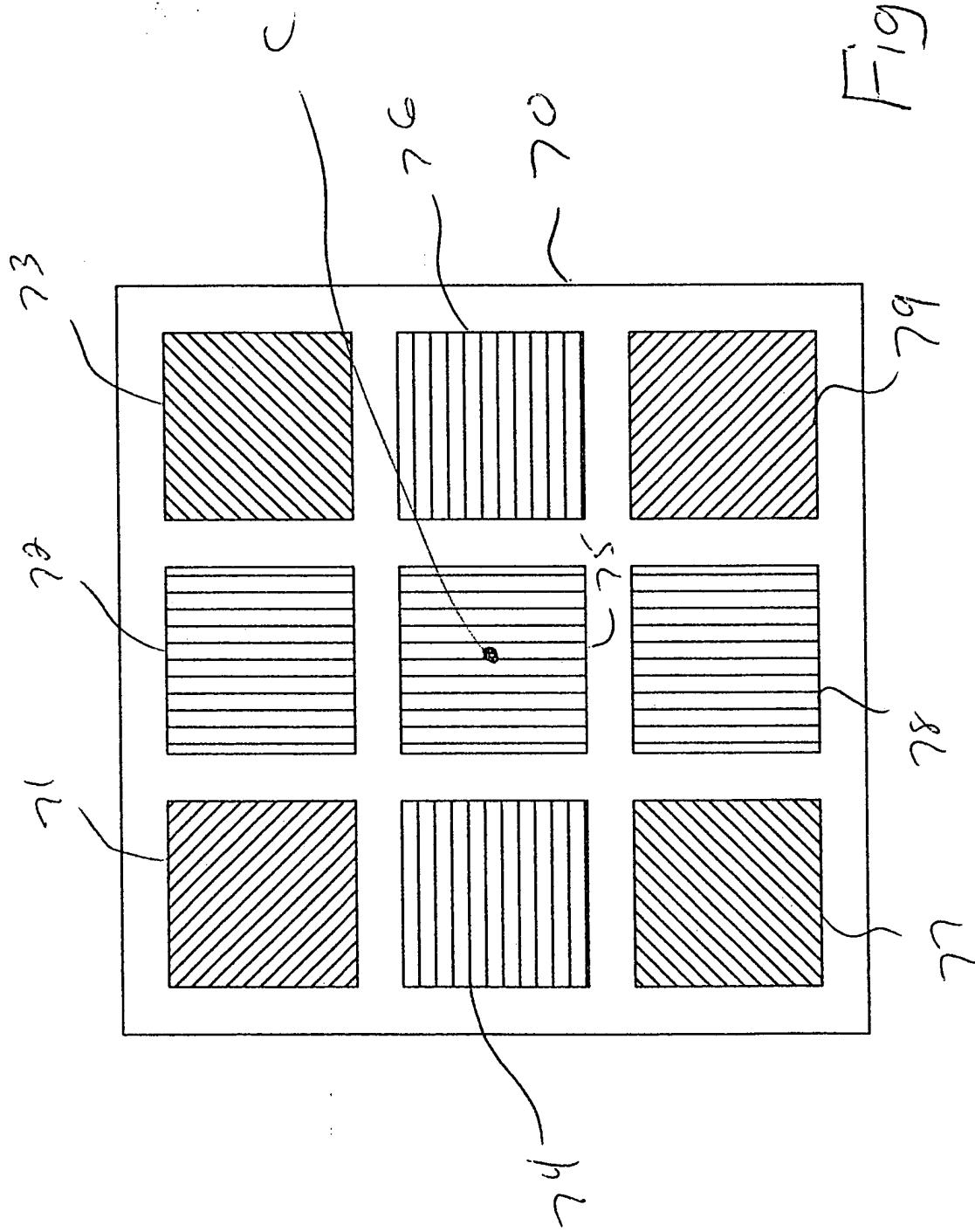
Fig. 6C

Fig. 6B

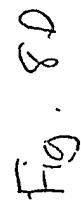
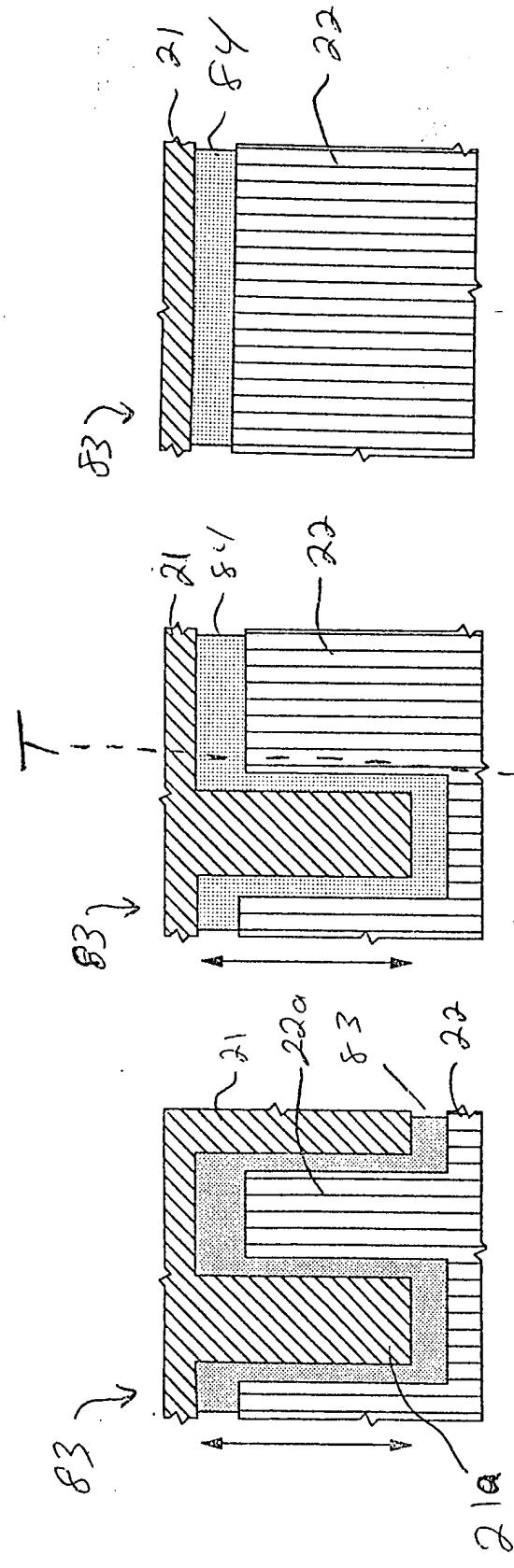
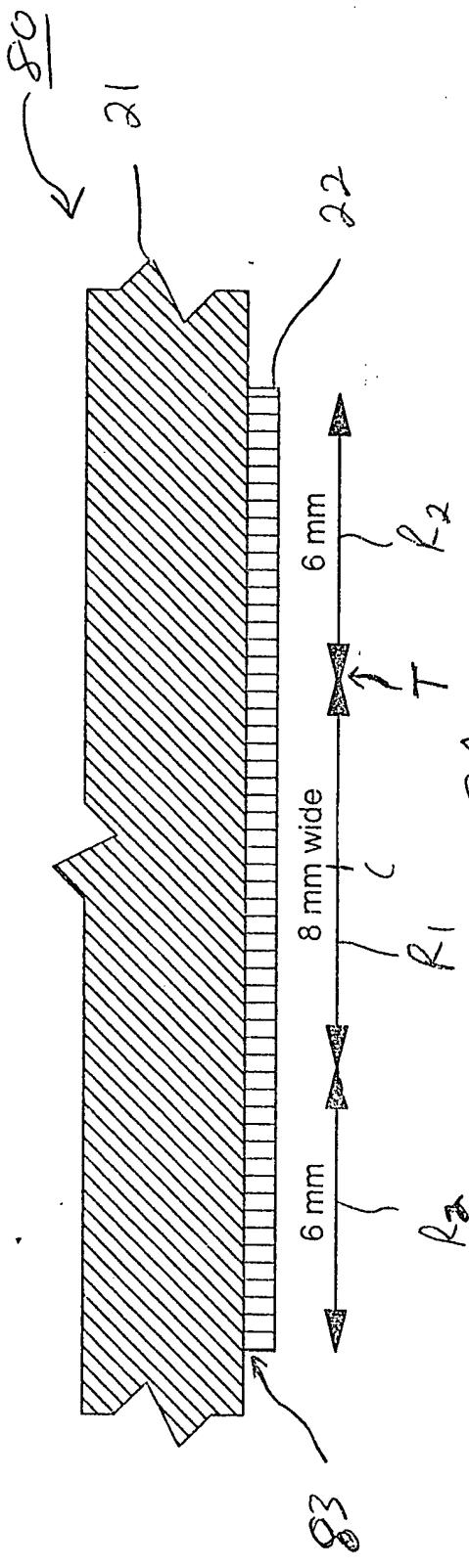
Fig. 6A

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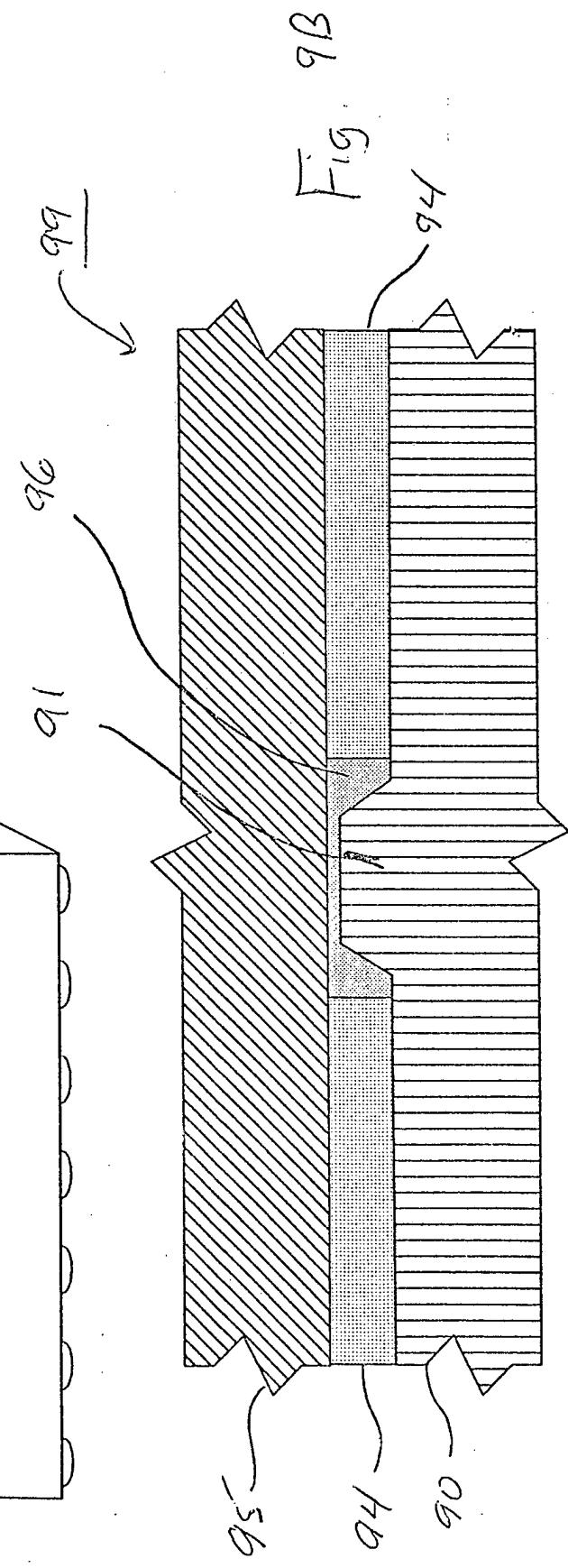
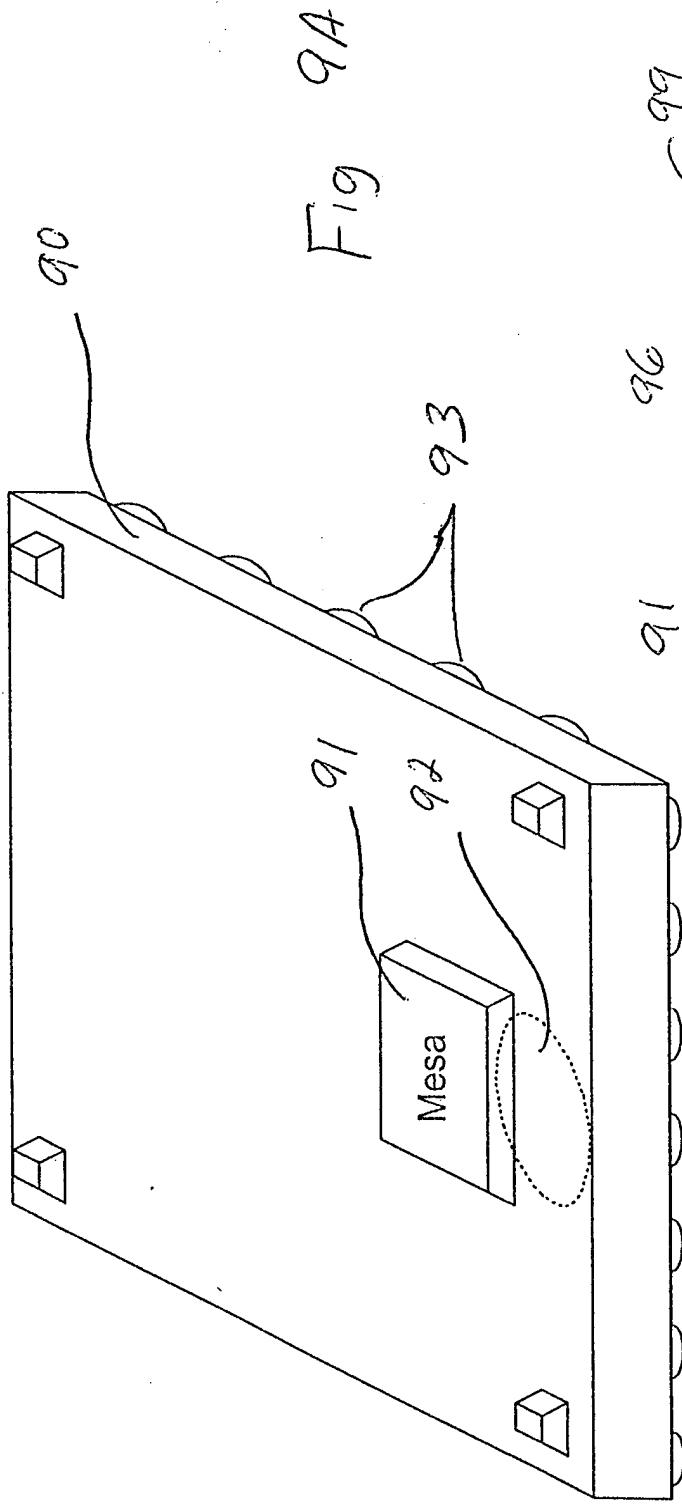
Fig. 7



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YOR920030527us1 (8728-665)

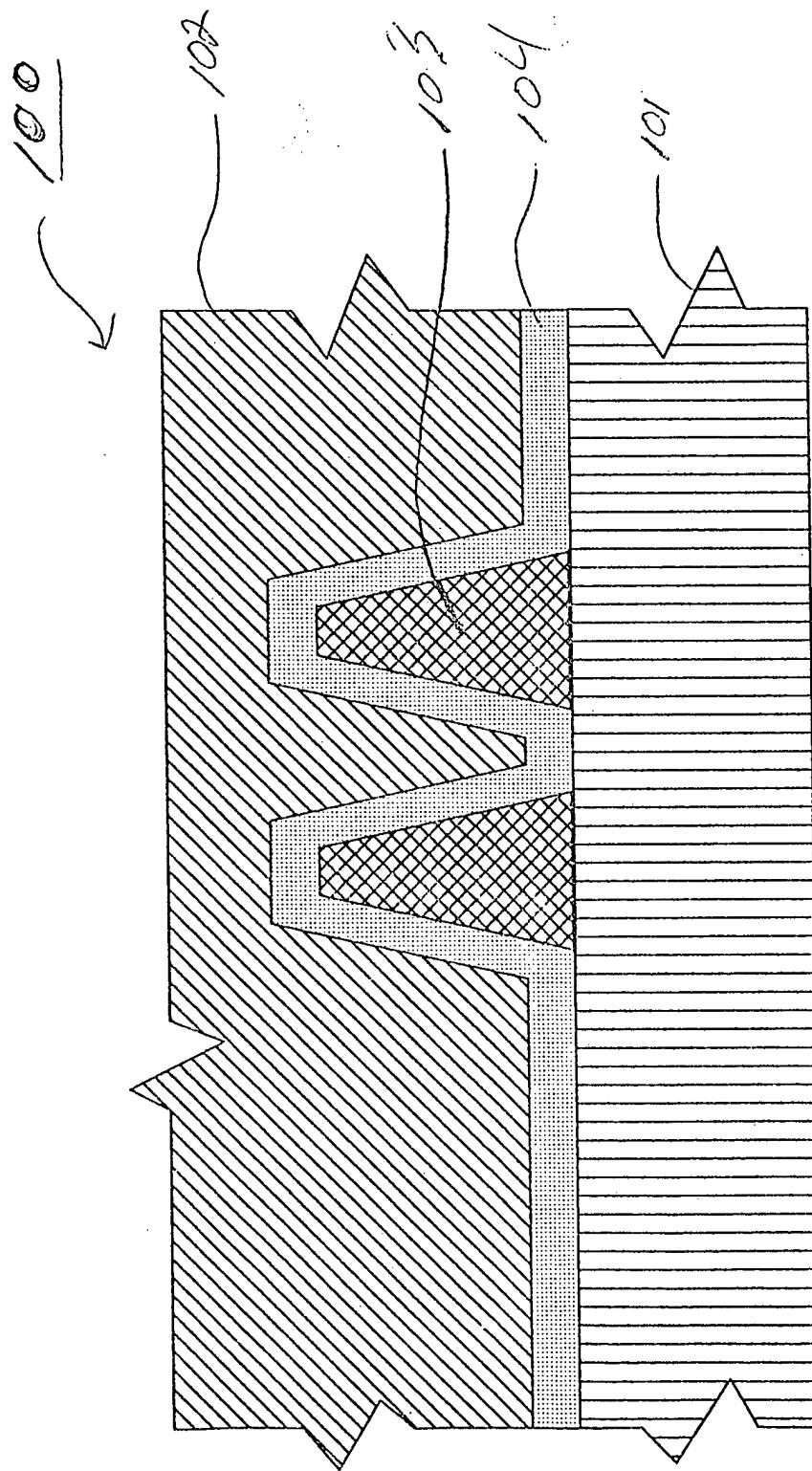


Fig. 10